

**Search Notes****Application/Control No.**

10/708,345

**Examiner**

Hai H. Huynh

**Applicant(s)/Patent under Reexamination**

YANG ET AL.

**Art Unit**

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	90.11	12/8/2005	HHH
123	90.15	12/8/2005	HHH
123	90.16	12/8/2005	HHH
123	90.17	12/8/2005	HHH
123	568.14	12/8/2005	HHH
123	295	12/8/2005	HHH
123	345-346	12/8/2005	HHH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	12/8/2005	HHH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner